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Residual stresses in chemically vapor deposited coatings in the Ti-C-N system

S. EROGLU(1) and B. GALLOIS

Department of Materials Science and Engineering, Stevens Institute of Technology, Hoboken, NJ 07030, U.S.A.

Abstract—Residual stresses in chemically vapor deposited monolithic and graded coatings in the Ti-C-N system were investigated as a function of substrate material and coating composition by X-ray diffraction (SinP) method. The thermal expansion coefficients (CTEs) of the graphite substrates ranged from 2.5x10^{-6} K^{-1} to 8.6x10^{-6} K^{-1}. Titanium nitride (CTE 9.35x10^{-6} K^{-1}) and titanium carbide (CTE 7.5x10^{-6} K^{-1}) coatings deposited on the low-expansion substrates (CTEs 2.5-3.5x10^{-6} K^{-1}) exhibited crack networks which accounted for low stress levels measured in the coatings. A phenomenological explanation of the crack patterns was given. The coatings grown on the substrates with high coefficients of thermal expansion (CTEs 7.8-8.6x10^{-6} K^{-1}) had no cracks. Residual stresses in the TiN coatings on these substrates were measured to be tensile. Whereas TiC coatings always exhibited compressive stresses ranging from -54±10 MPa to -288±18 MPa. The TiC_{x}N_{y} coatings deposited on the substrate with a thermal expansion coefficient of 8.6x10^{-6} K^{-1} also had compressive stresses increased with increasing TiC mole fraction in the TiC_{x}N_{y} up to about 0.9 above which stresses decreased. The residual stresses in the top TiC layers of the graded TiN/TiC coatings with linear, parabolic and exponential composition profiles grown on the same substrate (CTE 8.6x10^{-6} K^{-1}) were measured to be compressive and about 475 MPa. Stresses in the coatings were calculated and attributed to the thermal expansion mismatch between the coating and the substrate. It was shown that the measured stresses were, in general, found to be in good agreement with the calculated ones.

1. Introduction

Nearly all vapor-deposited coatings are found to be in a state of residual or internal stress. Internal stresses can affect the integrity of the coating either by producing cracks (tensile stress) or by buckling (compressive stress). They can also influence the fracture, wear and fatigue behavior and the corrosion resistance of the coating-substrate composite. Therefore, it is important to understand the levels and origins of internal stresses in the coatings.

Whereas stresses in thin films deposited by physical vapor deposition methods have been the subject of extensive research, there is a scarcity of published reliable information on the internal stresses in coatings synthesized by chemical vapor deposition (CVD) technique. The present study was undertaken in order to investigate the effect of

(1) Address for correspondence: TUBITAK, Marmara Research Center, Materials Research Division, P.O. Box 21, Gebze-Kocaeli, Turkey

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substrate and the coating composition on internal stresses in the deposits grown by CVD in the Ti-C-N system and on the coherence (e.g. the absence of cracks) of the coatings.

2. Experimental Details
2.1. Chemical Vapor Deposition

The depositions were carried out in a computer-controlled hot-wall chemical vapor deposition reactor at 10.7 kPa (80 Torr). The reactant gas ratios of 200H2:200N2:20TiCl4 (sccm) for TiN and 600H2:50CH4:20TiCl4 (sccm) for TiC were chosen to yield stoichiometric deposits. Chemical vapor deposition of TiC$_x$N$_y$ coatings was carried out at 1400 K and a total flow rate of 670 sccm for a growth time of 75 minutes. The experiments were divided into two series. In the first series, the total CH$_4$+N$_2$ flow rate was held constant at 370 sccm, whereas it was equal to 175 sccm in the second one. The ratio of CH$_4$ to CH$_4$+N$_2$ ($X_{CH4}$) was varied from 0 to 1 for constant TiCl$_4$ flow rate (20 sccm) and constant H$_2$ flow rates. The morphologies of the TiC$_x$N$_y$ coatings grown at a CH$_4$+N$_2$ flow rate of 370 sccm were whiskery and rough. The TiC$_x$N$_y$ coatings deposited at a CH$_4$+N$_2$ flow rate of 175 sccm, however, exhibited smoother surface morphologies. The deposition of graded TiN/TiC coatings were carried out by continuously varying the $X_{CH4}$ ratio in the range 0-1 at a constant CH$_4$+N$_2$ flow rate of 175 sccm. Detailed studies of the chemical vapor deposition of TiC$_x$N$_y$ coatings and the graded coatings were published elsewhere [1]. Texture analyses on these coatings were reported in Ref. [2].

The substrates were rectangles 2 cm x 1 cm, 1mm thick, cut from several types of graphite. The properties of the graphites are listed in Table I. The main difference among these materials is in the thermal expansion coefficient which ranges from 2.5x10$^{-6}$ K$^{-1}$ to 8.6x10$^{-6}$K$^{-1}$. TiN and TiC coatings were grown on all the substrates listed in the Table I in order to investigate the effect of the substrate on the internal stress. The graphite substrate with a thermal expansion coefficient of 8.6x10$^{-6}$ K$^{-1}$ was used for the TiC$_x$N$_y$ monolithic coatings with C/C+N ratios in the range 0-1 and for the graded TiN/TiC coatings.

<table>
<thead>
<tr>
<th>Substrate</th>
<th>Thermal Exp. Coefficient (x10$^{-6}$ K$^{-1}$)</th>
<th>Tensile Strength (MPa)</th>
<th>Compressive Strength (MPa)</th>
<th>Young's Modulus (MPa)</th>
<th>Poisson ratio (%Vol.)</th>
</tr>
</thead>
<tbody>
<tr>
<td>TS-1792$^{a}$</td>
<td>2.5</td>
<td>27</td>
<td>66.5</td>
<td>9.6</td>
<td>-</td>
</tr>
<tr>
<td>Vitr. Carbon$^{b}$</td>
<td>3.5</td>
<td>-</td>
<td>-</td>
<td>-</td>
<td>-</td>
</tr>
<tr>
<td>AXZ-5Q$^{c}$</td>
<td>7.8</td>
<td>34.5</td>
<td>97</td>
<td>9</td>
<td>28</td>
</tr>
<tr>
<td>AXM-5Q$^{c}$</td>
<td>8.2</td>
<td>48.3</td>
<td>124</td>
<td>10.3</td>
<td>23</td>
</tr>
<tr>
<td>AFX-5Q$^{c}$</td>
<td>8.4</td>
<td>65.5</td>
<td>145</td>
<td>11</td>
<td>20</td>
</tr>
<tr>
<td>ACF-10Q$^{c}$</td>
<td>8.6</td>
<td>69</td>
<td>186</td>
<td>11</td>
<td>21</td>
</tr>
</tbody>
</table>

a:Supplied by Union Carbide Corp.
b:Atomergic Chemetals Corp.
c:Poco graphite, Inc.

2.2. X-ray diffraction measurements of internal stress and lattice parameter

X-ray analyses were performed on a General Electric XRD-6 parafocusing diffractometer equipped with a copper tube and Ni K$_\alpha$ filter. A more precise description of the X-ray diffraction device is given elsewhere [3]. The lattice parameter of a stress-free silicon briquette was measured to be equal to 0.543040 ± 0.000006 nm, in excellent
agreement with the the published value of 0.54301 nm [4]. The residual stress measured in the silicon powder was equal to 3 MPa ± 12 MPa, which is very small as expected from the powder.

Internal stresses in the coatings were measured by the well-known \( \sin^2 \Psi \) method [5], where \( \Psi \) is the angle between the crystal planes and the sample surface. The \( K_{\text{a}} \) (511,333) or (422) reflections were used for the stress measurements. The measured profiles of the peaks were corrected for angular dependence of the Lorentz polarization and absorption factors. The peak position was then determined by fitting a parabola to the top part of the profile.

Precision lattice parameters perpendicular to the plane of the coating were measured using the \( K_{\text{a}} \) and \( K_{\text{a2}} \) reflections of the (511,333), (422), (420) and (331) crystal planes. The peak positions were determined by the method used for the stress measurements. The Nelson-Riley analysis [6] was applied to obtain the true lattice parameter.

3. Results and Discussion

The internal stresses in CVD coatings consist of intrinsic stress and extrinsic stress. Intrinsic stress is the stress induced during growth and arises from sources such as impurity incorporation and structural defects. Intrinsic stress is usually low in chemically vapor deposited coatings because of the annealing effect of this process which is carried out at high temperatures (generally 1300 K). Extrinsic stress results from the thermal expansion (or contraction) mismatch between a coating and its substrate. If the coefficients of thermal expansion differ, cooling from the deposition temperature \( (T_{\text{cvQ}}) \) to room temperature \( (T_r) \) will produce stress. This stress contribution known as thermal stress is predominant over the intrinsic stress for the chemically vapor deposited coatings.

The thermal stresses in a coating/substrate system can be calculated by using the theory of elasticity [7]:

\[
\sigma_i = E_i (\epsilon - \alpha_i \Delta T) / (1 - \nu_i)
\]

where \( \epsilon \) is the strain common to the substrate/coating composite, \( \alpha \) is the coefficient of thermal expansion, \( \sigma \) is the stress, \( \Delta T \) is the temperature change \( (T_r - T_{\text{cvQ}}) \), \( E \) is Young's modulus and \( \nu \) is Poisson's ratio. The subscript refers to the coating or the substrate. The strain is given by

\[
\epsilon = \frac{\sum E_i \alpha_i t_i \Delta T}{\sum E_i t_i (1 - \nu_i)}
\]

where \( t \) is thickness. For a thin coating on a thick substrate \( (t_c/t_s << 1) \), the stress in the coating is given by:

\[
\sigma_c = E_c (\alpha_s - \alpha_c) \Delta T / (1 - \nu_c)
\]

Eq. 3 is the conventional formula employed in the literature on thin films for calculating thermal stresses in the coatings. Above equations indicate that the thermal stress is influenced by the differences in properties of the substrate and the coating and thickness of the coating and substrate. The calculations of thermal stresses in TiC\(_N\), and graded TiN/TiC coatings required a knowledge of the coefficient of thermal coefficient and Young's modulus as a function of composition. Since such information is not available, it was assumed that the properties change linearly with the TiC mol fraction in TiC\(_N\). They were calculated using the following values given for pure TiN and TiC: \( E_{\text{TIC}} = 450 \) MPa, \( E_{\text{TiN}} = 250 \) MPa, \( \alpha_{\text{TiC}} = 7.5 \times 10^{-6} \) K\(^{-1}\) and \( \alpha_{\text{TiN}} = 9.35 \times 10^{-6} \) K\(^{-1}\). The
Poisson's ratio is equal to 0.2 for all the materials investigated here.

3.1. Effect of Substrate

The TiN and TiC coatings deposited on the substrate with low coefficients of thermal expansion (TS-1792 and vitreous carbon) exhibited low levels of stresses. The measured stresses in TiC coatings ranged from +66 MPa and -92 MPa. TiN coatings exhibited tensile stresses of the order of 40 MPa. This behavior is explained as follows: since the deposition process takes place at high temperatures, the major source of residual stress arises from the difference between the thermal expansion coefficients of the substrate and the coating. The thermal stress which developed during the cooling stage from the deposition temperature to room temperature is calculated to be tensile and of the order of 2000 MPa. Such high tensile stresses caused the coatings to crack and the thermal stresses developed during the cooling stage were relieved. It was observed that all the coatings deposited on the substrate with the low coefficients of thermal expansion exhibited crack networks.

The TiN and TiC coatings deposited on graphites with high thermal expansion coefficients (7.8-8.6×10^6 K⁻¹) exhibited no cracks because the thermal mismatch between the coating and the substrate was small and of the order of 15%. Table II shows the results of stress analyses for the TiN and TiC coatings deposited at 1425 K. As seen from the table, the sign of the stresses agrees with the calculations obtained from Eq. 3. The levels of stresses are, however, lower than the calculated ones. This result suggests that stress relaxation occurred in the substrate or the coating during cooling stage. A partial delamination of the coating could be responsible for such a relaxation.

Table II- Internal stresses in TiN and TiC coatings deposited at 1425 K on graphite substrates with high coefficients of thermal expansion.

<table>
<thead>
<tr>
<th>Thermal Expansion Coefficient of the Substrates (x10^6 K⁻¹)</th>
<th>Stress (MPa)</th>
<th>TiN</th>
<th>TiC</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>Measured</td>
<td>Calculated</td>
<td>Measured</td>
</tr>
<tr>
<td>7.8</td>
<td>+128±13</td>
<td>+416</td>
<td>-126±21</td>
</tr>
<tr>
<td>8.2</td>
<td>0±15</td>
<td>+278</td>
<td>-54±10</td>
</tr>
<tr>
<td>8.4</td>
<td>+141±21</td>
<td>+208</td>
<td>-288±18</td>
</tr>
<tr>
<td>8.6</td>
<td>0±12</td>
<td>+140</td>
<td>-162±5</td>
</tr>
</tbody>
</table>

3.1.1. Crack morphology

Fig. 1(a) shows a SEM micrograph of a typical coating surface which contains intersecting crack lines. The dominant feature of the micrograph is that the crack lines meet each other approximately at an angle of 90° and do not cross. The origin of this crack pattern can be explained qualitatively. The cracks form perpendicularly to the largest stresses in their vicinity. Once a crack has formed the stress perpendicular to the crack line is relieved. Any remaining stress near the crack must be in a direction parallel to it. If another crack that has started at any other place in the coating moves near the first crack, the second crack will begin to move more and more perpendicularly to the first crack line because the stress parallel to the first crack increasingly becomes smaller. If the second crack continues to propagate, it will meet the first one at an angle of 90°.

Fig. 1(b) shows a SEM micrograph of a crack junction at high
magnification. The clear sharp breaks of grain boundaries indicate that cracks did not form during chemical vapor deposition. The micrograph also shows cracks opening perpendicular to the coating surface indicating that tensile stress was in the plane of the coating. The crack lines follow grain boundaries suggesting intergranular fracture formation.

Fig. 1- Scanning electron micrographs of the surface morphologies of the TiN coatings grown on the low expansion substrate (CTE 2.5x10⁻⁶ K⁻¹), at magnifications of (a) 1500X and (b) 5000X, showing crack networks.

3.1.2. The effect of stress on lattice constant

The analysis on the (511,333), (422), (420) and (331) reflections revealed that the coatings exhibited sharp diffraction profiles and good separation of the K₁ and K₂ peaks, indicating that the coatings had small microstrains and good crystalline structures and no significant plastic deformation took place in the coatings during cooling from the deposition temperature to room temperature.

Lattice parameters perpendicular to the plane of the coating obtained from the Nelson-Riley analysis were plotted against residual stresses for the TiN coatings grown on the substrate with a coefficient of thermal expansion of 2.5x10⁻⁶ K⁻¹. It can be seen from Fig. 2 that as residual tensile stress increases, the lattice parameter perpendicular to the plane of the coating decreases because of the Poisson's ratio effect. The solid line with a slope of -6.1 x 10⁻⁷ nm/MPa was obtained from a linear least-square fit to the data. The dashed-dotted line with a slope of -6.8 x 10⁻⁷ nm/MPa was calculated by the following equation for isotropic plane stress in the coating [8]:

\[ \sigma = \frac{E}{2v} \left( \frac{a_0 - a}{a_0} \right) \]

where E and v are the Young's modulus and the Poisson's ratio of the coating, and \( a_0 \) and \( a \) are the unstrained bulk lattice parameter and the strained lattice parameter of the coating, respectively.

The stress-free lattice parameters were deduced by substituting \( \sigma = 0 \)
in the linear least-square fit to the data. The value deduced is 0.42400 nm which is in excellent agreement with the lattice parameter of stoichiometric titanium nitride, which is equal to 0.4240 nm [9].

![Lattice Parameter vs Residual Stress](image)

**Fig. 2** - The effect of residual stress measured in TiN coatings on the lattice constant perpendicular to the plane of the coating.

### 3.2. Effect of deposit composition

Fig. 3 shows the variation of internal stresses in TiC\textsubscript{N}\textsubscript{x} coatings with the composition of deposits. Stresses in pure TiN coatings were measured to be almost zero. The compressive internal stresses increased with increasing TiC content in the film up to a TiC mole fraction of about 0.90 above which stresses decreased to -270 Mpa. In order to explain this behavior, theoretical stresses were calculated using Eqs. 1 and 2. The calculated stresses are also plotted along with the measured ones in Fig. 3. In the TiN coatings, the calculated tensile stresses are of the order of 240 MPa and higher than those measured. Since the coating grown at a nitrogen flow rate of 370 sccm has whiskery features, such open structure could not sustain a mechanical force and the stress decreased to zero. However, the TiN deposit prepared at 175 sccm is dense and no cracks were observed in this coating. The calculated stresses in coatings with a TiC content ranging from 0.50 to 0.8 are in good agreement with the measured ones. The measured stresses at 0.91 and 0.97 are higher than the calculated ones. The reason for this behavior is not known. In nearly pure and pure TiC coatings, the calculated and measured stresses are in good agreement with each other.

Fig. 4 shows stress plots for the functional layer of TiC deposited on top of the graded TiN/TiC coatings. The internal stresses in the TiC layers were measured to be compressive. They were equal to -440, -475 and -500 MPa for the coatings with exponential, linear and parabolic composition profiles, respectively. As can be seen from the plots, all the data points lie on straight lines, indicating that there were no
stress gradients in the coatings. The theoretical stresses in the TiC layers were calculated using Eqs. 1 and 2. It was found that the calculated stresses were in good agreement with the measured ones (Fig. 4).

![Graph showing variation of residual stress in monolithic TiC coatings as a function of TiC mole fraction in TiC:Ny.](image)

**Fig. 3** - Variation of residual stress in the monolithic TiC<sub>x</sub>N<sub>y</sub> coatings as a function of TiC mole fraction in the TiC<sub>x</sub>N<sub>y</sub>.

<table>
<thead>
<tr>
<th>Grading</th>
<th>Measured stress (MPa)</th>
<th>Calculated stress (MPa)</th>
</tr>
</thead>
<tbody>
<tr>
<td>Linear</td>
<td>-475</td>
<td>-500</td>
</tr>
<tr>
<td>para.</td>
<td>-500</td>
<td>-525</td>
</tr>
<tr>
<td>expo.</td>
<td>-440</td>
<td>-416</td>
</tr>
</tbody>
</table>

![Graph showing X-ray stress plots for graded coatings.](image)

**Fig. 4** - X-ray stress plots for the graded coatings. Internal stresses were measured in the TiC top layers of the graded TiN/TiC coatings.
4. Conclusions

(1) TiN and TiC coatings grown on graphite substrates with low coefficients of thermal expansion exhibited extensive crack networks which relieved thermal stresses.

(2) No crack networks were observed in the coatings deposited on graphites which have coefficients of thermal expansion close to those of TiN and TiC. The tensile and compressive stresses were obtained in TiN and TiC coatings, respectively. The low levels of the residual stresses measured in these coatings could be due to the unknown sources of relaxation that might occur during the cooling stage.

(3) Compressive stresses in TiC_N coatings increased with increasing TiC mole fraction up to about 0.90 above which stresses decreased. The TiC layers of the graded coatings also exhibited compressive stresses.

(4) The calculated thermal stresses, in general, agreed with the measured ones.

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